

RELIABILITY REPORT
FOR

DS1994

Dallas Semiconductor

4401 South Beltwood Parkway
Dallas, TX 75244-3292

Prepared by:

Ken Wendel

Ken Wendel
Reliability Engineering Manager
Dallas Semiconductor
4401 South Beltwood Pkwy.
Dallas, TX 75244-3292
Email : ken.wendel@dalsemi.com
ph: 972-371-3726
fax: 972-371-6016
mbl: 214-435-6610

Conclusion:

The following qualification successfully meets the quality and reliability standards required of all Dallas Semiconductor products and processes:

DS1994

In addition, Dallas Semiconductor's continuous reliability monitor program ensures that all outgoing product will continue to meet Maxim's quality and reliability standards. The current status of the reliability monitor program can be viewed at <http://www.maxim-ic.com/TechSupport/dsreliability.html>.*

Module Description:

A description of this Module can be found in the product data sheet. You can find the product data sheet at http://dbserv.maxim-ic.com/l_datasheet3.cfm.*

Reliability Derating:

A module device consists of one or more IC's in a single, upward integrated, package. This package is assembled to include batteries, crystals, and other piece parts that make up the configuration of the Module. Because of either the complexity of the package or the included piece parts, standard high temperature reliability testing is not possible. Therefore, in order to determine the reliability of module products, the reliability of each of the piece parts is individually determined, then summed to determine the reliability of the integrated module product. If there are "n" significant components in the module then:

$$Fr(\text{module}) = Fr(1) + Fr(2) + Fr(3) + \dots + Fr(n)$$

Fr (module) = Failure rate of module
 Fr(n) = Failure rate of the nth component

Failure Rates are reported in FITs (Failures in Time) or MTTF (Mean Time To Failure). The FIT rate is related to MTTF by:

$$MTTF = 1/Fr$$

NOTE: MTTF is frequently used interchangeably with MTBF.

The calculated failure rate for this module/assembly is:

Module Device:	Quantity:	MTTF (Yrs):	FITs:
CRYSTAL	1	12458	9.2
DS2404	1	22107	5.2
BR1225	1	173708	0.7
Totals:		7619	15

The parameters used to calculate the module failure rate are as follows:

Cf: 60% **Ea: 0.7** **B: 0** **Tu: 25 °C** **Vu: 5.5 Volts**

The reliability data follows. At the start of this data is the module assembly information. This is a description of the module. The next section is the detailed reliability data for each stress found in the qualification / monitor. If there are additional processes or assemblies used as part of this report, a description of each will follow which includes the respective reliability data for that process/ assembly. The reliability data section includes the latest data available.

* Some proprietary products may be excepted from this requirement.

Assembly Information:

Qualification Vehicle: DS1992
 Assembly Site: Dallas
 Pin Count: 2
 Package Type: Puk Can F50 Insert Mold w/Bump/Battery
 Body Size: 0
 Mold Compound: ?
 Lead Frame: Printed Crt Brd; FR4
 Lead Finsh:
 Die Attach: Underfill FP4527, Dexter Hysol
 Bond Wire / Size: /
 Flammability: UL 94-V0
 Moisture Sensitivity (JEDEC J-STD20A)
 Date Code Range: 0234 to 0234

MECHANICAL LIFE

DESCRIPTION	DATE CODE	CONDITION	READPOINT	QUANTITY	FAILS
MECHANICAL SHOCK	0234	200G, 1/2 SINE, 6 MS	30 CYS	50	0
VIBRATION, VARIABLE F	0234	10g or 0.06", 5Hz-2KHz, X Y Z axis	9 HRS	50	0
MECHANICAL SHOCK	0234	200G, 1/2 SINE, 6 MS	30 CYS	50	0
VIBRATION, VARIABLE F	0234	10g or 0.06", 5Hz-2KHz, X Y Z axis	9 HRS	50	0
Total:					0

STORAGE LIFE

DESCRIPTION	DATE CODE	CONDITION	READPOINT	QUANTITY	FAILS
STORAGE LIFE	0234	85 C	1000 HRS	77	0
STORAGE LIFE	0234	85 C	1000 HRS	77	0
Total:					0

TEMPERATURE CYCLE

DESCRIPTION	DATE CODE	CONDITION	READPOINT	QUANTITY	FAILS
TEMP CYCLE	0234	-40 TO 85C	1000 CYS	77	0
TEMP CYCLE	0234	-40 TO 85C	1000 CYS	77	0
Total:					0

UNBIASED MOISTURE RESISTANCE

DESCRIPTION	DATE CODE	CONDITION	READPOINT	QUANTITY	FAILS
MOISTURE SOAK	0234	60C/90% R.H.	1000 HRS	77	0

MOISTURE SOAK	0234	60C/90% R.H.	1000 HRS	77	0
				Total:	0

Assembly Information:

Qualification Vehicle: DS1994
 Assembly Site: Dallas
 Pin Count: 2
 Package Type: Puk Can F50 Insert Mold w/Bump/Battery
 Body Size: 0
 Mold Compound: ?
 Lead Frame: Printed Crt Brd; FR4
 Lead Finish:
 Die Attach: Underfill FP4527, Dexter Hysol
 Bond Wire / Size: /
 Flammability: UL 94-V0
 Moisture Sensitivity
 (JEDEC J-STD20A)
 Date Code Range: 0232 to 0232

MECHANICAL LIFE

DESCRIPTION	DATE CODE	CONDITION	READPOINT	QUANTITY	FAILS
MECHANICAL SHOCK	0232	200G, 1/2 SINE, 6 MS	30 CYS	50	0
VIBRATION, VARIABLE F	0232	10g or 0.06", 5Hz-2KHz, X Y Z axis	9 HRS	50	0
				Total:	0

STORAGE LIFE

DESCRIPTION	DATE CODE	CONDITION	READPOINT	QUANTITY	FAILS
STORAGE LIFE	0232	85 C	1000 HRS	77	0
				Total:	0

TEMPERATURE CYCLE

DESCRIPTION	DATE CODE	CONDITION	READPOINT	QUANTITY	FAILS
TEMP CYCLE	0232	-40 TO 85C	1000 CYS	77	0
				Total:	0

UNBIASED MOISTURE RESISTANCE

DESCRIPTION	DATE CODE	CONDITION	READPOINT	QUANTITY	FAILS
MOISTURE SOAK	0232	60C/90% R.H.	1000 HRS	77	0
				Total:	0